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DATE MAILED: 09/15/2006

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/647,985	08/26/2003	Patricia Beauregard Smith	TI-33260	3087	
23494	7590 09/15/2006	EXAM	EXAMINER		
	STRUMENTS INCORF 5474, M/S 3999	EL ARINI,	EL ARINI, ZEINAB		
DALLAS, TX 75265			ART UNIT	PAPER NUMBER	
			1746	· - · · - ·	

Please find below and/or attached an Office communication concerning this application or proceeding.

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Office Action Summary		Application No.		Applicant(s)				
		10/647,985		SMITH ET AL.				
		Examiner		Art Unit				
		Zeinab E. EL		1746				
Period fo	The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
WHIC - Exter after - If NO - Failu Any	ORTENED STATUTORY PERIOD FOR REPLY CHEVER IS LONGER, FROM THE MAILING DATE in may be available under the provisions of 37 CFR 1.13 SIX (6) MONTHS from the mailing date of this communication. In period for reply is specified above, the maximum statutory period were to reply within the set or extended period for reply will, by statute, reply received by the Office later than three months after the mailing and patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS 36(a). In no event, will apply and will ex cause the applicat	COMMUNICATION however, may a reply be tim pire SIX (6) MONTHS from to	l. ely filed he mailing date of this c) (35 U.S.C. § 133)				
Status								
1) 又	Responsive to communication(s) filed on 30 Ju	ine 2006						
_								
	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is							
/_	closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
Disposition of Claims								
4)🛛	Claim(s) <u>1-6,8-15,17,18 and 20</u> is/are pending	in the applica	tion.					
	4a) Of the above claim(s) is/are withdrawn from consideration.							
_	Claim(s) is/are allowed.							
6)🖂	Claim(s) <u>1-6,8-15,17,18 and 20</u> is/are rejected.							
	Claim(s) is/are objected to.							
8) 🗌	Claim(s) are subject to restriction and/or	r election requ	uirement.	•				
Applicati	on Papers							
9)[]	The specification is objected to by the Examiner	r						
	The drawing(s) filed on is/are: a) acce		objected to by the F	xaminer.				
,—	Applicant may not request that any objection to the o	•	•	•				
					FR 1.121(d).			
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.								
Priority u	inder 35 U.S.C. § 119							
_	12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of:							
	1. Certified copies of the priority documents	s have been r	eceived.					
	2. Certified copies of the priority documents have been received in Application No							
	3. Copies of the certified copies of the priority documents have been received in this National Stage							
	application from the International Bureau (PCT Rule 17.2(a)).							
* See the attached detailed Office action for a list of the certified copies not received.								
Attachmen	• •		_					
1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413)								
2) Notice of Draftsperson's Patent Drawing Review (PTO-948) 3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date Notice of Informal Patent Application								
Paper No(s)/Mail Date 6) Other:								

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DETAILED ACTION

The amendment and remarks filed on 6/30/06 have been acknowledged and entered.

The rejections stated in paper No.031406 have been withdrawn in view of applicants' amendment.

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-6, 8-15, 17-18, and 20 are rejected under 35 U.S.C. 103(a) as being unpatentable over Chang et al.'518 or Chiu et al. or Nguyen et al. in combination with chang (5,643,407) and Smith et al. (2002/0058397).
- 3. Chang et al. disclose a method for cleaning wafer comprising the patterning step, the wet cleaning and the non-plasma annealing steps as claimed. The reference discloses the dielectric layer, performing a dry clean of the patterned dielectric layer to remove the photoresist prior to the wet cleaning. The reference also discloses the oxygen plasma, and high temperature annealing as claimed. See paragraphs 10-11, and 19-22.

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Chiu et al. disclose a method of cleaning a wafer comprising patterning, wet cleaning, the annealing, the plasma and the solvent as claimed. See col. 3, lines 11-65, and col. 8, lines 16-17 and 67.

Nguyen et al. disclose a method for cleaning a wafer comprising the patterning step, the plasma cleaning, wet cleaning, and the annealing as claimed. See paragraphs 5 and 7.

Chang et al.'518 or Chiu et al. or Nguyen et al. as discussed supra do not teach the low pressure anneal, the temperature, the time, and the acid as claimed.

Chang '407 discloses the low pressure annealing, the acid, and the temperature as claimed.

Smith et al. disclose the low pressure anneal, the metal deposition and removing the fluorine based solvent from a substrate.

It would have been obvious for one skilled in the art to use the acid, the temperature, and the low pressure annealing taught by Chang'407, and the low pressure annealing, the temperature, and removing the fluorine based solvent taught by Smith et al. in the Chang et al. or Chiu et al or Nguyen et al. process to obtain the claimed process. This is because low pressure annealing is well known in the semiconductor manufacturing process. This is also because all references are from the same technical endeavor, which is a method for cleaning and fabricating a substrate.

Response to Arguments

4. Applicant's arguments with respect to claims 1-6, 8-15, 17-18, and 20 have been considered but are most in view of the new ground(s) of rejection.

Conclusion

5. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Zeinab E. EL-Arini whose telephone number is (571) 272-1301. The examiner can normally be reached on Monday-Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Michael Barr can be reached on (571) 272-1414. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Zeinab Elarini Zeinab E. EL-Arini Primary Examiner Art Unit 1746 Page 5

ZEE 9/6/06